Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,973	TANABE, AKIRA	
Examiner	Art Unit	
SUCHIN PARIHAR	2825	

SEARCHED					
Class	Subclass	Date	Examiner		
716	4	3/13/2008	SP		
716	1	3/13/2008	SP		
257	347,611	3/13/2008	SP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	1, 4	3/13/2008	SP		
	I				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Text Search US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB	3/13/2008	SP		